ELSEVIER Nuclear Instruments and Methods in Physics Research A 458 (2001) 782–801

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PII: S0168-9002(01)00002-X

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High Energy Physics Detectors

Proceedings of the 11th International Workshop on Room Temperature Semiconductor X-and Gamma-Ray Detectors and Associated Electronics

International Atomic Energy Agency

Vienna, Austria, 11–15 October, 1999

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PII: S0168-9002(01)00003-1

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